

Test report No. : 11796546H-D
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Issued date : July 27, 2017
FCC ID : ZQU-D1150410

RADIO TEST REPORT

Test Report No.: 11796546H-D

Applicant : SINFONIA TECHNOLOGY CO.,LTD.

Type of Equipment : Digital Photo Printer

Model No. : CHC-S2245-5

Test regulation : FCC Part 15 Subpart C: 2017

FCC ID : ZQU-D1150410

Test Result : Complied

1. This test report shall not be reproduced in full or partial, without the written approval of UL Japan, Inc.

2. The results in this report apply only to the sample tested.

3. This sample tested is in compliance with above regulation.

4. The test results in this report are traceable to the national or international standards.

5. This test report must not be used by the customer to claim product certification, approval, or endorsement by NVLAP, NIST, or any agency of the Federal Government.

6. This test report covers Radio technical requirements. It does not cover administrative issues such as Manual or non-Radio test related Requirements. (if applicable)

Date of test:

June 5 to 16, 2017

Representative test engineer:

Masafumi Niwa

Engineer

Consumer Technology Division

Approved by:

Satofumi Matsuyama

Engineer

Consumer Technology Division



This laboratory is accredited by the NVLAP LAB CODE 200572-0, U.S.A. The tests reported herein have been performed in accordance with its terms of accreditation. *As for the range of Accreditation in NVLAP, you may refer to the WEB address,

http://japan.ul.com/resources/emc_accredited/

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REVISION HISTORY

Original Test Report No.: 11796546H-D

Revision	Test report No.	Date	Page revised	Contents
- (Original)	11796546H-D	July 27, 2017	-	-

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SECTION 1: Customer information

Company Name : SINFONIA TECHNOLOGY CO., LTD.

Address : 100-Takegahana-cho Ise-shi Mie-ken 516-8550 JAPAN

Telephone Number : +81-596-36-1286 Facsimile Number : +81-596-36-3884 Contact Person : Tsutomu Inagaki

SECTION 2: Equipment under test (E.U.T.)

2.1 Identification of E.U.T.

Type of Equipment : Digital Photo Printer Model No. : CHC-S2245-5

Serial No. : Refer to Section 4, Clause 4.2 Rating : AC 100 V to 240 V, 50/60 Hz

Receipt Date of Sample : June 1, 2017 Country of Mass-production : Japan

Condition of EUT : Production prototype

(Not for Sale: This sample is equivalent to mass-produced items.)

Modification of EUT : No Modification by the test lab

2.2 Product Description

Model: CHC-S2245-5 (referred to as the EUT in this report) is a Digital Photo Printer.

The EUT receive image data from a PC and print images.

General Information

The clock frequencies used in the EUT: : 24 MHz, CPU: Internal 375 MHz,

SDRM: 133 MHz, FPGA: 60 MHz/50 MHz, RFID: 13.56 MHz

Radio Specification

Radio Type : Transceiver
Frequency of Operation : 13.56 MHz
Modulation : ASK
Power Supply (inner) : DC 3.3 V
Antenna type : Pattern antenna
Clock frequency (Maximum) : 13.56 MHz

Operating Temperature : +10 deg. C to +35 deg. C

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SECTION 3: Test specification, procedures & results

3.1 Test Specification

Test Specification : FCC Part 15 Subpart C

FCC Part 15 final revised on June 14, 2017 and effective July 14, 2017

Title : FCC 47CFR Part15 Radio Frequency Device Subpart C Intentional Radiators

Section 15.207 Conducted limits

Section 15.225: Operation within the band 13.110-14.010MHz

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^{*} The revision on June 14, 2017, does not affect the test specification applied to the EUT.

^{*} Also the EUT complies with FCC Part 15 Subpart B.

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3.2 Procedures and results

Item	Test Procedure	Specification	Worst margin	Results	Remarks		
	ANSI C63.10:2013 6 Standard test methods	Section 15.207	[QP] 15.7 dB				
Conducted emission			0.16852 MHz, N [AV]	Complied	Radiated		
	<ic>RSS-Gen 8.8</ic>	<ic>RSS-Gen 8.8</ic>	8.4 dB 0.16852 MHz, N				
Electric Field Strength of Fundamental	ANSI C63.10:2013 6 Standard test methods	Section 15.225(a)	77.6 dB, 13.56000 MHz, QP,	Complied	Radiated		
Emission	<ic> RSS-Gen 6.4, 6.12</ic>	<ic>RSS-210 B.6</ic>	0 deg.				
Spectrum Mask	ANSI C63.10:2013 6 Standard test methods	Section 15.225(b)(c)	46.1 dB, 13.11000 MHz, QP,	Complied	Radiated		
	<ic>RSS-Gen 6.4, 6.13</ic>	<ic> RSS-210 B.6</ic>	0 deg.				
20dB Bandwidth	ANSI C63.10:2013 6 Standard test methods	Section15.215(c)	See data	Complied	Radiated		
	<ic> -</ic>	<ic> -</ic>					
Electric Field Strength of Spurious Emission		Section 15.209, Section 15.225 (d)	16.3 dB 135.600 MHz, Vertical, OP	Complied	Radiated		
	<ic>RSS-Gen 6.4, 6.13</ic>	<ic>RSS-210 B.6</ic>	, ,				
Frequency Tolerance	ANSI C63.10:2013 6 Standard test methods	Section 15.225(e)	See data	Complied	Radiated		
	<ic>RSS-Gen 6.11, 8.11</ic>	<ic> RSS-210 B.6</ic>					
Note: UL Japan, Inc.'s E	Note: UL Japan, Inc.'s EMI Work Procedures No. 13-EM-W0420 and 13-EM-W0422						

FCC Part 15.31 (e)

This EUT provides stable voltage (DC 3.3~V) constantly to RF Module through the regulator regardless of input voltage. Therefore, this EUT complies with the requirement.

However, the supply voltage was varied and tested at 85 % and 115 % of the nominal rated supply voltage during frequency tolerance test according to Section 15.225(e).

FCC Part 15.203 Antenna requirement

It is impossible for end users to replace the antenna, because the antenna is mounted inside of the EUT. Therefore, the equipment complies with the antenna requirement of Section 15.203.

3.3 Addition to standard

No.	Item	Test Procedure	Specification	Remarks	Deviation	Worst margin	Results
1	99 % Occupied	RSS-Gen 6.6	-	Radiated	N/A	N/A	N/A
	Band Width						

Other than above, no addition, exclusion nor deviation has been made from the standard.

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3.4 Uncertainty

EMI

The following uncertainties have been calculated to provide a confidence level of 95 % using a coverage factor k = 2.

Frequency range	Conducted emission using AMN(LISN) (+/-)
0.009 MHz -	3.5 dB
0.15 MHz	
0.15 MHz - 30 MHz	3.0 dB

Test distance	Radiated emission (+/-)		
	9 kHz - 30 MHz		
3 m	3.8 dB		
10 m	3.7 dB		

^{*}Measurement distance

		Radiated emission	n (Below 1 GHz)	
Polarity	(3 m*)(+/-)		(10 m*)(+/-)	
Polarity	30 MHz - 200 MHz	200 MHz - 1000 MHz	30 MHz - 200 MHz 200	200 MHz - 1000MHz
Horizontal	5.0 dB	5.3 dB	5.0 dB	5.0 dB
Vertical	4.7 dB	5.9 dB	5.0 dB	5.1 dB

^{*} Measurement distance

Frequency Tolerance	Uncertainty (+/-)
Frequency error	
Below 150 kHz	3.5 Hz
150 kHz - 13.56 MHz	3.5 Hz
13.56 MHz - 2500 MHz	111.9 Hz
2500 MHz - 6000 MHz	328.1 Hz

Conducted emission test

The data listed in this test report has enough margin, more than the site margin.

Radiated emission test (3 m)

The data listed in this test report has enough margin, more than the site margin.

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3.5 Test Location

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	IC Registration	Width x Depth x	Size of	Other
	Number	Height (m)	reference ground plane (m) / horizontal conducting plane	rooms
No.1 semi-anechoic chamber	2973C-1	19.2 x 11.2 x 7.7m	7.0 x 6.0m	No.1 Power source room
No.2 semi-anechoic chamber	2973C-2	7.5 x 5.8 x 5.2m	4.0 x 4.0m	-
No.3 semi-anechoic chamber	2973C-3	12.0 x 8.5 x 5.9m	6.8 x 5.75m	No.3 Preparation room
No.3 shielded room	-	4.0 x 6.0 x 2.7m	N/A	-
No.4 semi-anechoic chamber	2973C-4	12.0 x 8.5 x 5.9m	6.8 x 5.75m	No.4 Preparation room
No.4 shielded room	-	4.0 x 6.0 x 2.7m	N/A	-
No.5 semi-anechoic chamber	-	6.0 x 6.0 x 3.9m	6.0 x 6.0m	-
No.6 shielded room	-	4.0 x 4.5 x 2.7m	4.0 x 4.5m	-
No.6 measurement room	-	4.75 x 5.4 x 3.0m	4.75 x 4.15m	-
No.7 shielded room	-	4.7 x 7.5 x 2.7m	4.7 x 7.5m	-
No.8 measurement room	-	3.1 x 5.0 x 2.7m	N/A	-
No.9 measurement room	-	8.0 x 4.6 x 2.8m	2.4 x 2.4m	-
No.11 measurement room	-	6.2 x 4.7 x 3.0m	4.8 x 4.6m	-

^{*} Size of vertical conducting plane (for Conducted Emission test): 2.0 x 2.0m for No.1, No.2, No.3, and No.4 semi-anechoic chambers and No.3 and No.4 shielded rooms.

3.6 Test set up, Test data, and Test instruments

Refer to APPENDIX.

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SECTION 4: Operation of E.U.T. during testing

4.1 Operating Modes

The mode is used:

Mode	Remarks*	
Transmitting mode (Tx)	The EUT Transmits and Receives at the same	
time and there is no receiving mode.		
The EUT was operated in a manner similar to typical	use during the tests.	

Test Item	Operating mode*
Conducted emission	Tx Mod on, without Tag
	Tx Mod on, Terminated *1)
Electric Field Strength of Fundamental Emission	Tx Mod on, without Tag
Spectrum Mask	Tx Mod on, without Tag
20 dB Bandwidth	Tx Mod on, with Tag
99 % Occupied Bandwidth	Tx Mod on, without Tag
Electric Field Strength of Spurious Emission	Tx Mod on, without Tag
Frequency Tolerance	Tx Mod off

^{*} After the comparison of the test data between with Tag and without Tag, the tests were performed with the worst case.

Justification: The system was configured in typical fashion (as a user would normally use it) for testing.

Frequency Tolerance:

Temperature : -30 deg. C to +50 deg. C; Step 10 deg. C (-30deg.C: Reference)

Voltage : Normal Voltage AC 120 V

Maximum Voltage AC 138 V, Minimum Voltage AC 102 V (AC 120 V \pm 15 %)

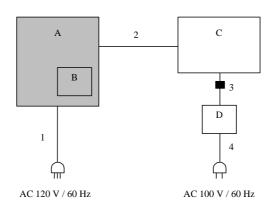
*This EUT provides stable voltage (DC 3.3 V) constantly to RF Part regardless of input voltage

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^{*1) 50} ohm termination was installed instead of the antenna.

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4.2 Configuration and peripherals



: Standard Ferrite Core

Description of EUT and Support equipment

	oberipuon of 201 una babbott equipment						
No.	Item	Model number	Serial number	Manufacturer	Remarks		
A	Digital Photo Printer	CHC-S2245-5	PP2-014	SINFONIA	EUT		
				TECHNOLOGY CO.,LTD.			
В	Ribbon Tag	AZ-H32+SLIX2	001	NXP Semiconductors N.V.	EUT		
С	Laptop PC	T410	R8-D74Hd	Lenovo	-		
D	AC adapter	92P1160	11S92P1160Z1ZBGH8	Lenovo	-		
			6PEAN				

List of cables used

No.	Name	Length (m)	Shi	ield	Remarks
			Cable		
1	AC Cable	1.4	Unshielded	Unshielded	-
2	USB Cable	1.6	Shielded	Shielded	-
3	DC Cable	1.8	Unshielded	Unshielded	-
4	AC Cable	0.8	Unshielded	Unshielded	-

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^{*} Cabling and setup(s) were taken into consideration and test data was taken under worse case conditions.

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SECTION 5: Conducted emission

Test Procedure and conditions

EUT was placed on a urethane platform of nominal size, 1.0 m by 1.5 m, raised 0.8 m above the conducting ground plane.

The rear of tabletop was located 40 cm to the vertical conducting plane. The rear of EUT, including peripherals aligned and flushed with rear of tabletop. All other surfaces of tabletop were at least 80 cm from any other grounded conducting surface. EUT was located 80 cm from a Line Impedance Stabilization Network (LISN)/ Artificial mains Network (AMN) and excess AC cable was bundled in center.

For the tests on EUT with other peripherals (as a whole system)

I/O cables that were connected to the peripherals were bundled in center. They were folded back and forth forming a bundle 30 cm to 40 cm long and were hanged at a 40 cm height to the ground plane. All unused 50 ohm connectors of the LISN (AMN) were resistivity terminated in 50 ohm when not connected to the measuring equipment.

The AC Mains Terminal Continuous disturbance Voltage has been measured with the EUT in a Semi Anechoic Chamber.

The EUT was connected to a LISN (AMN).

An overview sweep with peak detection has been performed.

The test results and limit are rounded off to one decimal place, so some differences might be observed.

Detector : QP and CISPR AV Measurement range : 0.15 MHz - 30 MHz

Test data : APPENDIX

Test result : Pass

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SECTION 6: Radiated emission (Fundamental, Spurious Emission and Spectrum Mask)

Test Procedure

EUT was placed on a urethane platform of nominal size, 1.0 m by 1.5 m, raised 0.8 m above the conducting ground plane. The Radiated Electric Field Strength has been measured in a Semi Anechoic Chamber with a ground plane.

Frequency: From 9 kHz to 30 MHz

The EUT was rotated a full revolution in order to obtain the maximum value of the electric field intensity.

The measurements were performed for vertical polarization (antenna angle: 0 deg., 45 deg., 90 deg., and 135 deg.) and horizontal polarization.

*Refer to Figure 1 about Direction of the Loop Antenna.

Frequency: From 30 MHz to 1 GHz

The measuring antenna height varied between 1 and 4 m and EUT was rotated a full revolution in order to obtain the maximum value of the electric field intensity.

The measurements were performed for both vertical and horizontal antenna polarization.

The test was made with the detector (RBW/VBW) in the following table.

When using Spectrum analyzer, the test was made with adjusting span to zero by using peak hold.

Test Antennas are used as below;

Frequency	Below 30 MHz	30 MHz to 200 MHz	200 MHz to 1 GHz
Antenna Type	Loop	Biconical	Logperiodic

Frequency	From 9 kHz to	From 90 kHz to 110	From 150 kHz	From 490 kHz	From 30 MHz
	90 kHz	kHz	to 490 kHz	to 30 MHz	to 1 GHz
	and				
	From 110 kHz to				
	150 kHz				
Instrument used			Test Receiver		
Detector	PK / AV	QP	PK / AV	QP	QP
IF Bandwidth	200 Hz	200 Hz	9 kHz	9 kHz	120 kHz
Test Distance	3 m *1)	3 m *1)	3 m *1)	3 m *2)	3 m

^{*1)} Distance Factor: $40 \times \log (3 \text{ m} / 300 \text{ m}) = -80 \text{ dB}$

Although these tests were performed other than open field test site, adequate comparison measurements were confirmed against 30 m open field test site. Therefore sufficient tests were made to demonstrate that the alternative site produces results that correlate with the ones of tests made in an open field based on KDB 414788.

These tests were performed in semi anechoic chamber. Therefore the measured level of emissions may be higher than if measurements were made without a ground plane.

However test results were confirmed to pass against standard limit.

The test was made on EUT at the normal use position.

The test results and limit are rounded off to one decimal place, so some differences might be observed.

Measurement range : 9 kHz - 1 GHz Test data : APPENDIX 1

Test result : Pass

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^{*2)} Distance Factor: $40 \times \log (3 \text{ m} / 30 \text{ m}) = -40 \text{ dB}$

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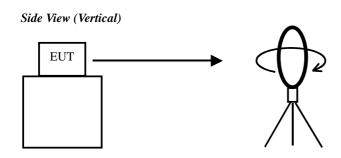
SECTION 7: Other test

Test	Span	RBW	VBW	Sweep	Detector	Trace	Instrument used
20 dB Bandwidth	200 kHz	3.6 kHz	11 kHz	Auto	Peak	Max Hold	Spectrum Analyzer
99 % Occupied Bandwidth	Enough width to display emission skirts	1 to 5 % of OBW	Three times of RBW	Auto	Peak *1)	Max Hold *1)	Spectrum Analyzer
Frequency Tolerance	-	-	-	-	-	-	Frequency Counter

^{*1)} The measurement was performed with Peak detector, Max Hold since the duty cycle was not 100 %. Peak hold was applied as Worst-case measurement.

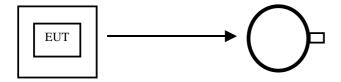
Test data : APPENDIX
Test result : Pass

Figure 1: Direction of the Loop Antenna



.......

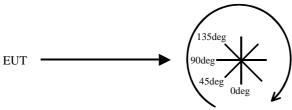
Top View (Horizontal)



Antenna was not rotated.

......

Top View (Vertical)



Front side: 0 deg.

Forward direction: clockwise

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APPENDIX 1: Test data

Conducted emission

DATA OF CONDUCTED EMISSION TEST

UL Japan, Inc. Ise EMC Lab. No.2 Semi Anechoic Chamber Date: 2017/06/05

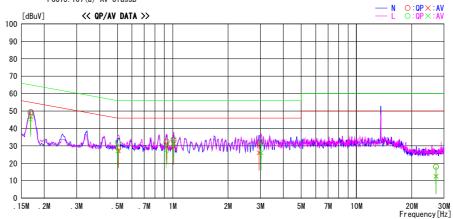
: 11796546H

Temp./Humi. : 22deg. C / 40% RH Engineer : Shuichi Ohyama

Report No.

Mode / Remarks : Tx 13.56 MHz without Tag

LIMIT : FCC15.107(a) QP ClassB FCC15.107(a) AV ClassB



F	Reading	Level	Corr.	Resi	ılts	Lin	iit	Mar	gin		
Frequency	QP	AV	Factor	QP	AV	QP	AV	QP	AV	Phase	Comment
[MHz]	[dBuV]	[dBuV]	[dB]	[dBuV]	[dBuV]	[dBuV]	[dBuV]	[dB]	[dB]		
0. 16852	36. 1	33. 4	13. 2	49.3	46. 6	65.0	55.0	15. 7	8. 4	N	
0. 50582	15.3	14. 0	13.3	28. 6	27. 3	56.0	46.0	27. 4	18. 7	N	
0. 92737	19.1	16.3	13.3	32.4	29. 6	56.0	46.0	23. 6	16.4	N	
1. 01192	19.8	16. 1	13.3	33. 1	29. 4	56.0	46.0	22. 9	16.6	N	
2. 95115		12.4	13.6	31.6	26. 0	56.0	46.0	24. 4	20.0	N	
27. 12000		-2. 7	15.3	18.0		60.0	50.0	42. 0	37. 4	N	
0. 16854		32. 0		48. 4	45. 2	65.0	55.0	16.6	9.8	L	
0. 50229		13. 8	13.3	32.0		56.0	46. 0	24. 0	18. 9	L	
0. 92173	18. 2	13. 9	13.3	31.5	27. 2	56.0	46.0	24. 5	18.8	L	
1. 01144		17. 6		34. 0		56.0	46. 0	22. 0	15. 1	L	
3. 03364		12. 5		32. 1	26. 1	56.0	46. 0	23. 9	19.9		
27. 12000	2. 7	-2. 8	15.3	18.0	12. 5	60.0	50.0	42. 0	37. 5	L	

CHART: WITH FACTOR, Peak hold data. CALCULATION: RESULT = READING + C.F(LISN + ATTEN + CABLE) Except for the above table : adequate margin data below the limits.

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Conducted emission

DATA OF CONDUCTED EMISSION TEST

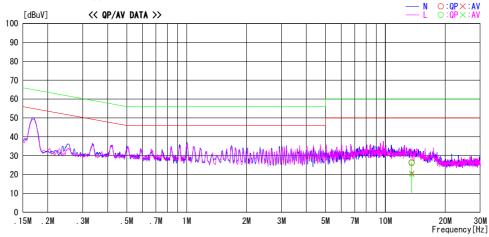
Ise EMC Lab. No.3 Semi Anechoic Chamber Date: 2017/06/16

Report No. : 11796546H

: 24deg. C / 32% RH : Masafumi Niwa Temp./Humi. Engineer

Mode / Remarks : Tx 13.56 MHz Terminated

LIMIT : FCC15.107(a) QP ClassB FCC15.107(a) AV ClassB



F	Reading	Level	Corr.	Resu	ılts	Lir	nit	Mar	gin		
Frequency	QP	AV	Factor	QP	AV	QP	AV	QP	AV	Phase	Comment
[MHz]	[dBuV]	[dBuV]	[dB]	[dBuV]	[dBuV]	[dBuV]	[dBuV]	[dB]	[dB]		
13.56000	12. 2	6. 5	14. 2	26. 4	20. 7	60.0		33. 6	29. 3	N	
13.56000	11.9	5. 7	14. 2	26. 1	19. 9	60.0	50.0	33.9	30.1	L	
ļ											
											1

CHART: WITH FACTOR, Peak hold data. CALCULATION: RESULT = READING + C.F(LISN + ATTEN + CABLE) Except for the above table : adequate margin data below the limits.

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Fundamental emission and Spectrum Mask

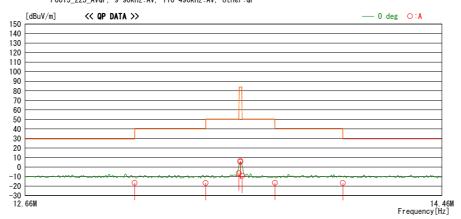
DATA OF RADIATED EMISSION TEST UI, Japan, Inc. Ise EMC Lab.

No.2 semi-anechoic chamber Date : 2017/06/06

Report No. : 11796546H

: 24deg. C / 43% RH : Masafumi Niwa

Mode / Remarks : Tx 13.56MHz without tag



Freq.	Reading	DET	Ant. Fac	Loss	Gain	Result	Limit	Margin	Antenna		Table	Comment
[MHz]	[dBuV]		[dB/m]	[dB]	[dB]	[dBuV/m]	[dBuV/m]	[dB]	[deg]		[deg]	
13.11000	29. 2	QP	19. 4	-32. 9	32. 3	-16.6	29. 5	46. 1	0	Α	0	
13.41000	29. 1	QP	19.4	-32.9	32.3	-16.7	40.5	57. 2	0	Α	0	
13.55300	39.3	QP	19.4	-32. 9	32.3	-6.5	50.4	56. 9	0	Α	0	
13.56000	52. 1	QP	19.4	-32.9	32.3			77. 6	0	Α	0	
13.56000	51.2	QP	19. 4	-32. 9	32. 3	5.4	83.9	78. 5	0	Α	0	with tag
13.56700	36. 7	QP	19.4	-32. 9	32. 3		50.4	59. 5		A	0	
13.71000	29. 2	QP	19. 4	-32. 9	32. 3		40.5	57. 1	0	A	0	
14.01000	29. 1	QP	19.4	-32. 9	32. 3	-16.7	29. 5	46. 2	0	Α	0	

Result of the fundamental emission at 3 m without Distance factor

Q	QP													
	Ant Deg [deg]	Frequency	Detector	Reading	Ant	Loss	Gain	Duty	Result	Limit	Margin	Remark		
					Factor			Factor						
		[MHz]		[dBuV]	[dB/m]	[dB]	[dB]	[dB]	[dBuV/m]	[dBuV/m]	[dB]			
Г	0	13.56000	QP	52.1	19.4	7.1	32.3	-	46.3	-	-	Fundamental		
_														

 $Result = Reading + Ant\ Factor + Loss\ (Cable + Attenuator + Filter) - Gain (Amprifier)$

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: 11796546H-D Test report No. Page : 17 of 24 **Issued date** : July 27, 2017 FCC ID : ZQU-D1150410

Spurious emission

DATA OF RADIATED EMISSION TEST

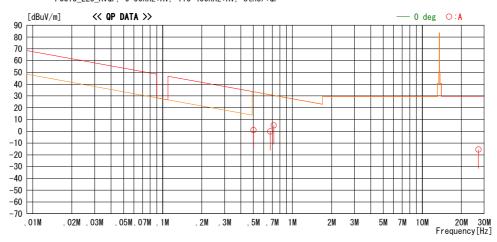
Japan, Inc. Ise EMC Lab. No.2 semi-anechoic chamber Date : 2017/06/06

Report No. : 11796546H

Temp. / Humi. : 24deg. C / 43% RH : Masafumi Niwa

Mode / Remarks : Tx 13.56MHz without tag

LIMIT : FCC15_225_PKQP, 9-90kHz:PK, 110-490kHz:PK, other:QP FCC15_225_AVQP, 9-90kHz:AV, 110-490kHz:AV, other:QP



Freq.	Reading	DET	Ant. Fac	Loss	Gain	Result	Limit	Margin	Antenna		Table	Comment
[MHz]	[dBuV]		[dB/m]	[dB]	[dB]	[dBuV/m]	[dBuV/m]	[dB]	[deg]		[deg]	
0.50100	47. 6	QP	19. 5				33. 6	32. 6	0	Α	11	
0. 67414		QP	19.5						0	Α	26 72	
0. 71836			19.5							A		
27. 12000	28. 8	QP	20. 3	-32. 4	32. 2	-15.5	29. 5	45. 0	0	A	0	
	i i											

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Spurious emission

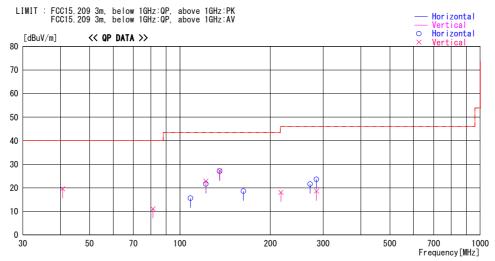
DATA OF RADIATED EMISSION TEST

UL Japan, Inc. Ise EMC Lab. No.3 Semi Anechoic Chamber

Report No. : 11796546H

Temp./Humi. : 24 deg. C / 32 % RH Engineer : Masafumi Niwa

Mode / Remarks : Tx 13.56MHz without tag



Frequency	Reading	DET	Antenna Factor	Loss& Gain	Level	Angle	Height	Polar.	Limit	Margin	Comment
[MHz]	[dBuV]	DEI	[dB/m]	[dB]	[dBuV/m]	[Deg]	[cm]	Total.	[dBuV/m]	[dB]	COMMISSION
40. 680	30. 4	QP	14. 1	-24. 9	19. 6	247	100	Vert.	40.0	20. 4	
81.360	28. 8	QP	6. 6	-24. 3	11. 1	96	135	Vert.	40.0	28. 9	
108. 480	28. 2	QP	11.3	-23. 9	15. 6	202	291	Hori.	43. 5	27.9	
122. 040	33. 4	QP	13. 2	-23.8	22. 8	356	103	Vert.	43.5	20.7	
122. 040	32. 3	QP	13. 2	-23.8	21. 7	202	145	Hori.	43.5	21.8	
135. 600	36. 5	QP	14. 2	-23.5	27. 2	172	100	Vert.	43.5	16.3	
135. 600	36. 4	QP	14. 2	-23.5	27. 1	194		Hori.	43.5		
162. 720	26. 3	QP	15. 6	-23. 3	18. 6	23	178	Hori.	43. 5	24. 9	
216.960	29. 3	QP	11.6	-22. 8	18. 1	271	100	Vert.	46.0	27. 9	
271. 200	31. 3	QP	12. 5	-22. 2	21. 6	94		Hori.	46.0	24. 4	
284. 760	27. 8	QP	12. 9	-22. 1	18. 6	324	249	Vert.	46.0	27.4	
284. 760	32. 8	QP	12. 9	-22. 1	23. 6	110	101	Hori.	46.0	22.4	

CHART: WITH FACTOR ANT TYPE: -30MHz:LOOP, 30-200MHz:BICONICAL, 200MHz-1000MHz:LOGPERIODIC, 1000MHz-:HORN CALCULATION: RESULT = READING + ANT FACTOR + LOSS & GAIN(CABLE + ATTEN - GAIN(AMP))

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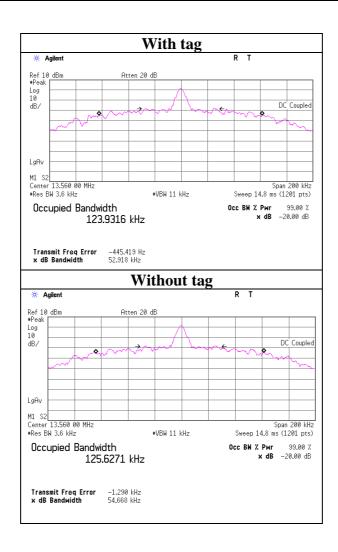
20dB Bandwidth and 99% Occupied Bandwidth

Test place Ise EMC Lab. No.11 measurement room

Report No. 11796546H Date 06/08/2017

Temperature/ Humidity 25 deg. C / 56 % RH Engineer Masafumi Niwa Mode Tx Mod on

FREQ	Mode	20dB Bandwidth	99% Occupied Bandwidth
[MHz]		[kHz]	[kHz]
12.56	With Tag	52.92	123.93
13.56	Without Tag	54.67	125.63



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Frequency Tolerance

Test place Ise EMC Lab. No.11 measurement room

Report No. 11796546H
Date 06/08/2017
Temperature/ Humidity 25 deg. C / 56 % RH
Engineer Masafumi Niwa
Mode Tx Mod off

Test co	ondition	Tested	Measured	Frequency	Res	sult	Limit
Temp.	Voltage	timing	frequency	error			
[deg. C]	[V]		[MHz]	[MHz]	[%]	[ppm]	[+/- %]
50	120	Power on	13.559528	-0.000472	-0.00348	-34.8	0.01
		+ 2 min.	13.559523	-0.000477	-0.00352	-35.2	0.01
		+ 5 min.	13.559521	-0.000479	-0.00353	-35.3	0.01
		+ 10 min.	13.559519	-0.000481	-0.00354	-35.4	0.01
40	120	Power on	13.559561	-0.000439	-0.00324	-32.4	0.01
		+ 2 min.	13.559547	-0.000453	-0.00334	-33.4	0.01
		+ 5 min.	13.559542	-0.000458	-0.00338	-33.8	0.01
		+ 10 min.	13.559540	-0.000460	-0.00339	-33.9	0.01
30	120	Power on	13.559587	-0.000413	-0.00304	-30.4	0.01
		+ 2 min.	13.559585	-0.000415	-0.00306	-30.6	0.01
		+ 5 min.	13.559578	-0.000422	-0.00311	-31.1	0.01
		+ 10 min.	13.559575	-0.000425	-0.00314	-31.4	0.01
20	120	Power on	13.559634	-0.000366	-0.00270	-27.0	0.01
		+ 2 min.	13.559627	-0.000373	-0.00275	-27.5	0.01
		+ 5 min.	13.559625	-0.000376	-0.00277	-27.7	0.01
		+ 10 min.	13.559623	-0.000377	-0.00278	-27.8	0.01
20	102	Power on	13.559637	-0.000363	-0.00268	-26.8	0.01
	(120V -15%)	+ 2 min.	13.559625	-0.000375	-0.00277	-27.7	0.01
		+ 5 min.	13.559623	-0.000377	-0.00278	-27.8	0.01
		+ 10 min.	13.559620	-0.000380	-0.00280	-28.0	0.01
20	138	Power on	13.559630	-0.000370	-0.00273	-27.3	0.01
	(120V +15%)	+ 2 min.	13.559623	-0.000377	-0.00278	-27.8	0.01
		+ 5 min.	13.559620	-0.000380	-0.00280	-28.0	0.01
		+ 10 min.	13.559619	-0.000381	-0.00281	-28.1	0.01
10	120	Power on	13.559672	-0.000328	-0.00242	-24.2	0.01
		+ 2 min.	13.559663	-0.000337	-0.00249	-24.9	0.01
		+ 5 min.	13.559657	-0.000343	-0.00253	-25.3	0.01
		+ 10 min.	13.559655	-0.000345	-0.00254	-25.4	0.01
0	120	Power on	13.559683	-0.000317	-0.00234	-23.4	0.01
		+ 2 min.	13.559683	-0.000317	-0.00234	-23.4	0.01
		+ 5 min.	13.559680	-0.000320	-0.00236	-23.6	0.01
		+ 10 min.	13.559679	-0.000321	-0.00237	-23.7	0.01
-10	120	Power on	13.559674	-0.000326	-0.00240	-24.0	0.01
		+ 2 min.	13.559654	-0.000346	-0.00255	-25.5	0.01
		+ 5 min.	13.559689	-0.000311	-0.00229	-22.9	0.01
		+ 10 min.	13.559689	-0.000311	-0.00229	-22.9	0.01
-20	120	Power on	13.559633	-0.000367	-0.00271	-27.1	0.01
		+ 2 min.	13.559665	-0.000336	-0.00247	-24.7	0.01
		+ 5 min.	13.559673	-0.000327	-0.00241	-24.1	0.01
		+ 10 min.	13.559675	-0.000325	-0.00240	-24.0	0.01
-30	120	Power on	13.559579	-0.000421	-0.00310	-31.0	0.01
		+ 2 min.	13.559619	-0.000381	-0.00281	-28.1	0.01
		+ 5 min.	13.559635	-0.000365	-0.00269	-26.9	0.01
		+ 10 min.	13.559637	-0.000363	-0.00267	-26.7	0.01

Calculation formula: Frequency error = Measured frequency - Tested frequency Result [%] = Frequency error / Tested frequency * 100

Tested frequency: 13.56 MHz

Limit (+/-): 0.01 % (+/- 100ppm)

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^{*}The test was begun from 50 deg. C and the temperature was lowered each 10 deg. C.

^{*}As for the range of specification operating temperature, the test was performed with required temperature range on Frequency Tolerance.

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APPENDIX 2: Test instruments

EMI test equipment

Control No.	ipment Instrument	Manufacturer	Model No	Serial No	Test Item	Calibration Date *
						Interval(month)
MAEC-02	Semi Anechoic	TDK	Semi Anechoic	DA-06902	CE,RE	2016/08/02 * 12
	Chamber(NSA)		Chamber 3m			
MOS-22	Thermo-Hygrometer	Custom	CTH-201	0003	CE,RE	2016/12/13 * 12
MJM-14	Measure	KOMELON	KMC-36	-	CE,RE	=
COTS-MEMI	EMI measurement	TSJ	TEPTO-DV	-	CE,RE	-
	program					
MTR-03	Test Receiver	Rohde & Schwarz	ESCI	100300	CE	2016/10/21 * 12
MLS-23	LISN(AMN)	Schwarzbeck	NSLK8127	8127-729	CE(EUT)	2016/07/07 * 12
MLS-24	LISN(AMN)	Schwarzbeck	NSLK8127	8127-730	CE(AE)	2016/07/11 * 12
MTA-51	Terminator	TME	CT-01BP	-	CE	2016/12/01 * 12
MCC-13	Coaxial Cable	Fujikura	3D-2W(12m)/	-	CE	2017/02/24 * 12
			5D-2W(5m)/			
			5D-2W(0.8m)/			
			5D-2W(1m)			
MAT-65	Attenuator(13dB)	JFW Industries, Inc.	50FP-013H2 N	-	CE	2016/12/21 * 12
MMM-01	Digital Tester	Fluke	FLUKE 26-3	78030611	CE,RE	2016/08/23 * 12
MLPA-01	Loop Antenna	Rohde & Schwarz	HFH2-Z2	100017	RE	2016/10/14 * 12
MCC-143	Coaxial Cable	UL Japan	-	-	RE	2017/06/12 * 12
MPA-13	Pre Amplifier	SONOMA INSTRUMENT	310	260834	RE,CE	2017/03/27 * 12
MAT-07	Attenuator(6dB)	Weinschel Corp	2	BK7970	RE	2016/11/28 * 12
MAEC-03	Semi Anechoic Chamber(NSA)	TDK	Semi Anechoic Chamber 3m	DA-10005	RE,CE	2016/10/20 * 12
MOS-13	Thermo-Hygrometer	Custom	CTH-180	1301	RE,CE	2017/01/20 * 12
MJM-16	Measure	KOMELON	KMC-36	-	RE,CE	=
MSA-04	Spectrum Analyzer	Agilent	E4448A	US44300523	RE,CE	2016/11/10 * 12
MTR-08	Test Receiver	Rohde & Schwarz	ESCI	100767	RE,CE	2016/09/15 * 12
MBA-03	Biconical Antenna	Schwarzbeck	BBA9106	1915	RE	2016/10/15 * 12
MLA-22	Logperiodic Antenna(200-1000MHz)	Schwarzbeck	VUSLP9111B	911B-191	RE	2017/01/26 * 12
MCC-51	Coaxial cable	UL Japan	-	-	RE	2016/07/26 * 12
MAT-98	Attenuator	KEYSIGHT	8491A	MY52462349	RE	2016/12/05 * 12
MMM-08	DIGITAL HITESTER	Hioki	3805	051201197	RE	2017/01/19 * 12
MCC-112	Coaxial cable	Fujikura/Suhner/TSJ	5D-2W(10m)/ SFM141(3m)/ sucoform141-PE(1m)/	-/00640	CE	2016/07/26 * 12
			421-010(1.5m)/ RFM-E321(Switcher)			
MAT-66	Attenuator(13dB)	JFW Industries, Inc.	50FP-013H2 N	-	CE	2016/12/24 * 12
MFC-01	Microwave Counter	Advantest	R5373	120100309	FT	2016/06/01 * 12
MLPA-07	Loop Antenna	UL Japan	-	-	FT	Pre Check
MCH-04	Temperature and Humidity Chamber	Tabai Espec	PL-2KP	14015723	FT	2016/08/30 * 12
MMM-12	DIGITAL HITESTER	Hioki	3805	060500120	FT	2017/02/15 * 12
MOS-14	Thermo-Hygrometer	Custom	CTH-201	1401	FT	2017/01/20 * 12

The expiration date of the calibration is the end of the expired month.

All equipment is calibrated with valid calibrations. Each measurement data is traceable to the national or international standards.

As for some calibrations performed after the tested dates, those test equipment have been controlled by means of an unbroken chains of calibrations.

Test Item:

CE: Conducted Emission, RE: Radiated Emission, FT: Frequency Tolerance

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